

<b>Notice of References Cited</b>	Application/Control No. 09/651,944	Applicant(s)/Patent Under Reexamination- DRAPKIN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5,808,488	09-1998	Brucoleri et al.	327	57
	B	US-				
	C	US-				
	D	US-				
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	F	US-				
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	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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